

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,795	FURUSATO ET AL.	
Examiner	Art Unit	
Tu T. Nguyen	2886	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	5/25/2007	TN	
356/72, 73, 300>334 250/461.2, 461.1, 459.1, 206, 208.2 359/850	5/25/2007	TN	
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